Octal buffer/line driver; 3-state Rev. 4 — 24 September 2012

**Product data sheet** 

#### 1. **General description**

The 74HC244; 74HCT244 is an 8-bit buffer/line driver with 3-state outputs. The device can be used as two 4-bit buffers or one 8-bit buffer. The device features two output enables (1OE and 2OE), each controlling four of the 3-state outputs. A HIGH on nOE causes the outputs to assume a high-impedance OFF-state. Inputs include clamp diodes that enable the use of current limiting resistors to interface inputs to voltages in excess of V<sub>CC</sub>.

#### **Features and benefits** 2.

- Input levels:
  - For 74HC244: CMOS level
  - For 74HCT244: TTL level
- Octal bus interface
- Non-inverting 3-state outputs
- Complies with JEDEC standard no. 7 A
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
    - MM JESD22-A115-A exceeds 200 V
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C

#### **Ordering information** 3.

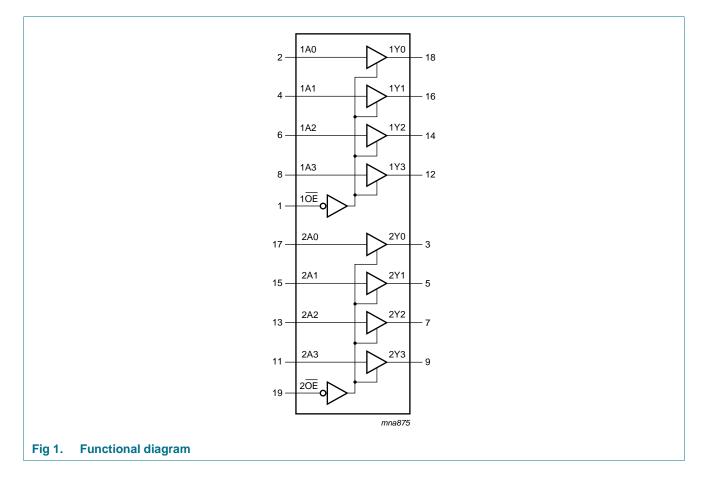
#### **Ordering information** Table 1.

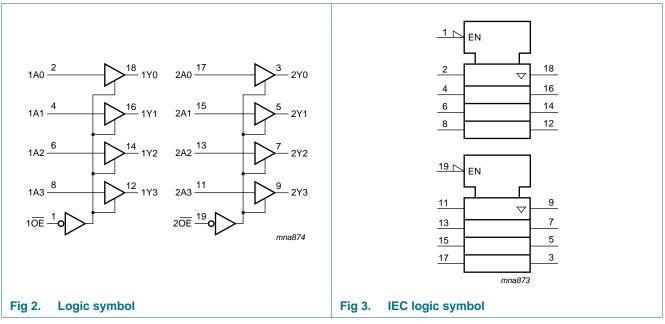
Type number	Package			
	Temperature range	Name	Description	Version
74HC244N	–40 °C to +125 °C	DIP20	plastic dual in-line package; 20 leads (300 mil)	SOT146-1
74HCT244N				
74HC244D	–40 °C to +125 °C	SO20	plastic small outline package; 20 leads;	SOT163-1
74HCT244D			body width 7.5 mm	
74HC244DB	–40 °C to +125 °C	SSOP20	plastic shrink small outline package; 20 leads;	SOT339-1
74HCT244DB			body width 5.3 mm	
74HC244PW	–40 °C to +125 °C	TSSOP20	plastic thin shrink small outline package; 20 leads;	SOT360-1
74HCT244PW			body width 4.4 mm	
74HC244BQ	–40 °C to +125 °C	DHVQFN20	plastic dual-in-line compatible thermal enhanced	SOT764-1
74HCT244BQ			very thin quad flat package; no leads; 20 terminals; body 2.5 $\times$ 4.5 $\times$ 0.85 mm	



Octal buffer/line driver; 3-state

# 4. Functional diagram



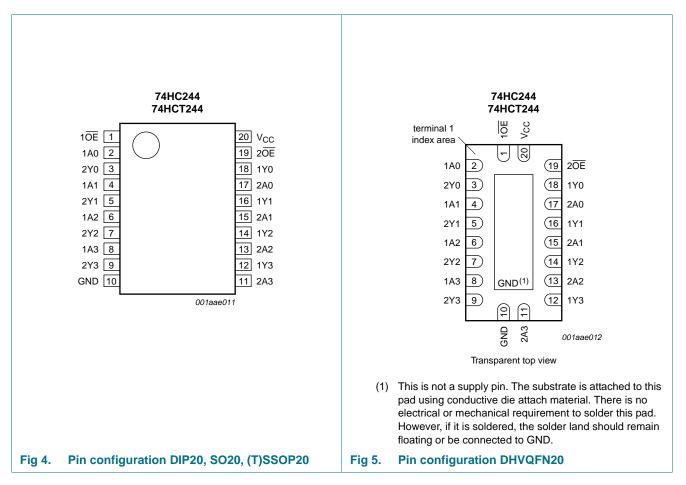


74HC\_HCT244
Product data sheet

Octal buffer/line driver; 3-state

# 5. Pinning information

## 5.1 Pinning



## 5.2 Pin description

Table 2. Pin descrip	otion	
Symbol	Pin	Description
1 <u>0E</u> , 2 <u>0E</u>	1, 19	output enable input (active LOW)
1A0, 1A1, 1A2, 1A3	2, 4, 6, 8	data input
2Y0, 2Y1, 2Y2, 2Y3	3, 5, 7, 9	bus output
GND	10	ground (0 V)
2A0, 2A1, 2A2, 2A3	17, 15, 13, 11	data input
1Y0, 1Y1, 1Y2, 1Y3	18, 16, 14, 12	bus output
V <sub>CC</sub>	20	supply voltage

## 6. Functional description

Table 3.	Function table <sup>[1]</sup>		
Input nOE			Output
nOE		nAn	nYn
L		L	L
L		Н	Н
Н		Х	Z

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; Z = high-impedance OFF-state.

# 7. Limiting values

### Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+7	V
I <sub>IK</sub>	input clamping current	$V_{\rm I}$ < -0.5 V or $V_{\rm I}$ > $V_{\rm CC}$ + 0.5 V	-	±20	mA
Ι <sub>ΟΚ</sub>	output clamping current	$V_{\rm O}$ < –0.5 V or $V_{\rm O}$ > $V_{\rm CC}$ + 0.5 V	-	±20	mA
I <sub>O</sub>	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	-	±35	mA
I <sub>CC</sub>	supply current		-	70	mA
I <sub>GND</sub>	ground current		-70	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	DIP20 package	<u>[1]</u> _	750	mW
		SO20, SSOP20, TSSOP20 and DHVQFN20 packages	[2] _	500	mW

[1] For DIP20 package: Ptot derates linearly with 12 mW/K above 70 °C.

For SO20 packages: P<sub>tot</sub> derates linearly with 8 mW/K above 70 °C.
 For SSOP20 and TSSOP20 packages: P<sub>tot</sub> derates linearly with 5.5 mW/K above 60 °C.
 For DHVQFN20 packages: above 60 °C, P<sub>tot</sub> derates linearly with 4.5 mW/K.

## 8. Recommended operating conditions

**Performanded operating conditions** 

Table 5.	Recommended operating conditions							
Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
74HC244								
V <sub>CC</sub>	supply voltage		2.0	5.0	6.0	V		
VI	input voltage		0	-	V <sub>CC</sub>	V		
Vo	output voltage		0	-	$V_{CC}$	V		
$\Delta t/\Delta V$	input transition rise and fall rate	$V_{CC} = 2.0 V$	-	-	625	ns/V		
		$V_{CC} = 4.5 V$	-	1.67	139	ns/V		
		$V_{CC} = 6.0 V$	-	-	83	ns/V		
T <sub>amb</sub>	ambient temperature		-40	-	+125	°C		

74HC HCT244

Table 5

4 of 18

## **NXP Semiconductors**

# 74HC244; 74HCT244

Octal buffer/line driver; 3-state

Table 5.	. Recommended operating conditions continued									
Symbol	Parameter	Conditions	Min	Тур	Мах	Unit				
74HCT24	4									
V <sub>CC</sub>	supply voltage		4.5	5.0	5.5	V				
VI	input voltage		0	-	V <sub>CC</sub>	V				
Vo	output voltage		0	-	V <sub>CC</sub>	V				
$\Delta t / \Delta V$	input transition rise and	d fall rate $V_{CC} = 4.5 V$	-	1.67	139	ns/V				
T <sub>amb</sub>	ambient temperature		-40	-	+125	°C				

#### Recommended operating conditions continued Table 5

#### **Static characteristics** 9.

#### Table 6. **Static characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		–40 °C t	o +85 °C	-40 °C to	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC24	4									
VIH	HIGH-level	V <sub>CC</sub> = 2.0 V	1.5	1.2	-	1.5	-	1.5	-	V
	input voltage	V <sub>CC</sub> = 4.5 V	3.15	2.4	-	3.15	-	3.15	-	V
		V <sub>CC</sub> = 6.0 V	4.2	3.2	-	4.2	-	4.2	-	V
V <sub>IL</sub>	LOW-level	V <sub>CC</sub> = 2.0 V	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	V <sub>CC</sub> = 4.5 V	-	2.1	1.35	-	1.35	-	1.35	V
		V <sub>CC</sub> = 6.0 V	-	2.8	1.8	-	1.8	-	1.8	V
V <sub>ОН</sub>	HIGH-level	$V_{I} = V_{IH} \text{ or } V_{IL}$								
	output voltage	$I_{O}$ = -20 $\mu$ A; $V_{CC}$ = 2.0 V	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -20 \ \mu\text{A}; \ V_{CC} = 4.5 \ \text{V}$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_O = -20 \ \mu\text{A}; \ V_{CC} = 6.0 \ \text{V}$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O}$ = -6.0 mA; $V_{CC}$ = 4.5 V	3.98	4.32	-	3.84	-	3.7	-	V
		$I_{O} = -7.8 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	5.34	-	5.2	-	V
V <sub>OL</sub>	LOW-level	$V_{I} = V_{IH} \text{ or } V_{IL}$								
	output voltage	$I_0 = 20 \ \mu A; \ V_{CC} = 2.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_0 = 20 \ \mu A; \ V_{CC} = 4.5 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_0 = 20 \ \mu A; \ V_{CC} = 6.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_{O}$ = 6.0 mA; $V_{CC}$ = 4.5 V	-	0.15	0.26	-	0.33	-	0.4	V
		$I_{O}$ = 7.8 mA; $V_{CC}$ = 6.0 V	-	0.16	0.26	-	0.33	-	0.4	V
l <sub>l</sub>	input leakage current	$V_{I} = V_{CC}$ or GND; $V_{CC} = 6.0 V$	-	-	±0.1	-	±1.0	-	±1.0	μΑ
I <sub>OZ</sub>	OFF-state output current	per input pin; $V_I = V_{IH}$ or $V_{IL}$ ; $V_O = V_{CC}$ or GND; other inputs at $V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$ ; $I_O = 0 \text{ A}$	-	-	±0.5	-	±5.0	-	±10	μΑ
I <sub>CC</sub>	supply current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{CC} \text{ or } GND; \ I_{O} = 0 \ A; \\ V_{CC} = 6.0 \ V \end{array}$	-	-	8.0	-	80	-	160	μΑ
CI	input capacitance		-	3.5	-	-	-	-	-	pF

Octal buffer/line driver; 3-state

Symbol	Parameter	Conditions		25 °C		–40 °C t	o +85 °C	–40 °C to	o +125 ℃	Unit
				Тур	Max	Min	Max	Min	Max	
74HCT2	44									1
V <sub>IH</sub>	HIGH-level input voltage	$V_{CC}$ = 4.5 V to 5.5 V	2.0	1.6	-	2.0	-	2.0	-	V
V <sub>IL</sub>	LOW-level input voltage	$V_{CC}$ = 4.5 V to 5.5 V	-	1.2	0.8	-	0.8	-	0.8	V
V <sub>ОН</sub>	HIGH-level	$V_{I} = V_{IH} \text{ or } V_{IL}; V_{CC} = 4.5 \text{ V}$								
	output voltage	I <sub>O</sub> = -20 μA	4.4	4.5	-	4.4	-	4.4	-	V
		I <sub>O</sub> = -6 mA	3.98	4.32	-	3.84	-	3.7	-	V
V <sub>OL</sub>	LOW-level	$V_{I} = V_{IH} \text{ or } V_{IL}; V_{CC} = 4.5 \text{ V}$								
output vo	output voltage	I <sub>O</sub> = 20 μA	-	0	0.1	-	0.1	-	0.1	V
		l <sub>O</sub> = 6.0 mA	-	0.16	0.26	-	0.33	-	0.4	V
lı –	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 V$	-	-	±0.1	-	±1.0	-	±1.0	μΑ
I <sub>OZ</sub>	OFF-state output current	per input pin; $V_I = V_{IH}$ or $V_{IL}$ ; $V_O = V_{CC}$ or GND; other inputs at $V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$ ; $I_O = 0 \text{ A}$	-	-	±0.5	-	±5.0	-	±10	μΑ
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5$ V; $I_O = 0$ A	-	-	8.0	-	80	-	160	μΑ
ΔI <sub>CC</sub>	additional supply current	per input pin; $V_I = V_{CC} - 2.1 V$ ; other inputs at $V_{CC}$ or GND; $V_{CC} = 4.5 V$ to 5.5 V; $I_O = 0 A$	-	70	252	-	315	-	343	μΑ
CI	input capacitance		-	3.5	-	-	-	-	-	pF

#### Table 6. Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

# **10. Dynamic characteristics**

#### Table 7. Dynamic characteristics

### GND = 0 V; for load circuit see <u>Figure 8</u>.

Symbol	Parameter	Conditions		25 °C			-40 °C to	Unit	
				Min	Тур	Max	Max (85 °C)	Max (125 °C)	
74HC244	4								
t <sub>pd</sub> p	propagation delay	nAn to nYn;	[1]						
		see <u>Figure 6</u>							
		$V_{CC} = 2.0 V$		-	30	110	145	165	ns
		$V_{CC} = 4.5 V$		-	11	22	28	33	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	9	-	-	-	ns
		V <sub>CC</sub> = 6.0 V		-	9	19	24	28	ns

Symbol	Parameter	Conditions			25 °C		-40 °C to	o +125 °C	Unit
				Min	Тур	Мах	Max (85 °C)	Max (125 °C)	
t <sub>en</sub>	enable time	nOE to nYn; see Figure 7	[2]		1		1	1	
		$V_{CC} = 2.0 V$		-	36	150	190	225	ns
		$V_{CC} = 4.5 V$		-	13	30	38	45	ns
		$V_{CC} = 6.0 V$		-	10	26	33	38	ns
t <sub>dis</sub>	disable time	nOE to nYn or see Figure 7	[3]						
		$V_{CC} = 2.0 V$		-	39	150	190	225	ns
		$V_{CC} = 4.5 V$		-	14	30	38	45	ns
		$V_{CC} = 6.0 V$		-	11	26	33	38	ns
tt transition time		see Figure 6	[4]						
		$V_{CC} = 2.0 V$		-	14	60	75	90	ns
		$V_{CC} = 4.5 V$		-	5	12	15	18	ns
		$V_{CC} = 6.0 V$		-	4	10	13	15	ns
C <sub>PD</sub>	power dissipation capacitance	per buffer; $V_I = GND$ to $V_{CC}$	<u>[5]</u>	-	35	-	-	-	pF
74HCT24	14								
pd	propagation delay	nAn to nYn;	[1]						
		see Figure 6							
		$V_{CC} = 4.5 V$		-	13	22	28	33	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$		-	11	-	-	-	ns
en	enable time	n <del>OE</del> to nYn; V <sub>CC</sub> = 4.5 V; see <u>Figure 7</u>	[2]	-	15	30	38	45	ns
dis	disable time	$n\overline{OE}$ to nYn; V <sub>CC</sub> = 4.5 V; see Figure 7	<u>[3]</u>	-	15	25	31	38	ns
t	transition time	V <sub>CC</sub> = 4.5 V; see <u>Figure 6</u>	[4]	-	5	12	15	18	ns
C <sub>PD</sub>	power dissipation capacitance	per buffer; V <sub>I</sub> = GND to V <sub>CC</sub> – 1.5 V	[5]	-	35	-	-	-	pF

# Table 7.Dynamic characteristics ... continuedGND = 0 V; for load circuit see Figure 8.

 $\label{eq:tpd} [1] \quad t_{pd} \text{ is the same as } t_{PHL} \text{ and } t_{PLH}.$ 

 $\label{eq:tensor} \begin{tabular}{c} [2] & t_{en} \mbox{ is the same as } t_{PZH} \mbox{ and } t_{PZL}. \end{tabular}$ 

 $\label{eq:tdis} [3] \quad t_{dis} \mbox{ is the same as } t_{PHZ} \mbox{ and } t_{PLZ}.$ 

 $[4] \quad t_t \text{ is the same as } t_{THL} \text{ and } t_{TLH}.$ 

[5]  $C_{PD}$  is used to determine the dynamic power dissipation (P<sub>D</sub> in  $\mu$ W):  $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$  where:

 $f_i$  = input frequency in MHz;

 $f_o = output$  frequency in MHz;

 $C_L$  = output load capacitance in pF;

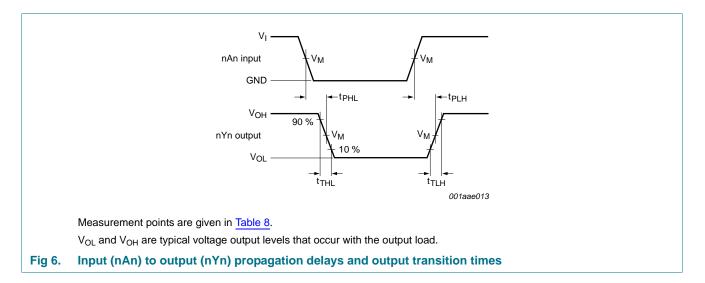
 $V_{CC}$  = supply voltage in V;

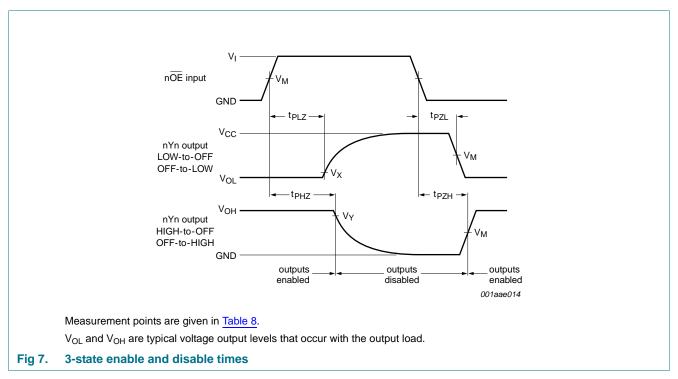
N = number of inputs switching;

 $\Sigma (C_L \times V_{CC}^2 \times f_o)$  = sum of outputs.

Octal buffer/line driver; 3-state

## 11. Waveforms





### Table 8. Measurement points

Туре	Input	Output					
	V <sub>M</sub>	V <sub>M</sub>	V <sub>X</sub>	V <sub>Y</sub>			
74HC244	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	$0.1 \times V_{CC}$	$0.9 \times V_{CC}$			
74HCT244	1.3 V	1.3 V	$0.1\times V_{CC}$	$0.9  imes V_{CC}$			

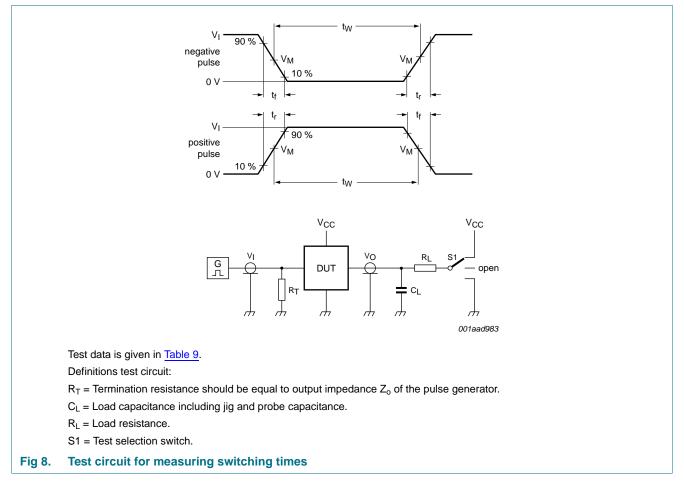
74HC\_HCT244
Product data sheet

8 of 18

## **NXP Semiconductors**

# 74HC244; 74HCT244

### Octal buffer/line driver; 3-state

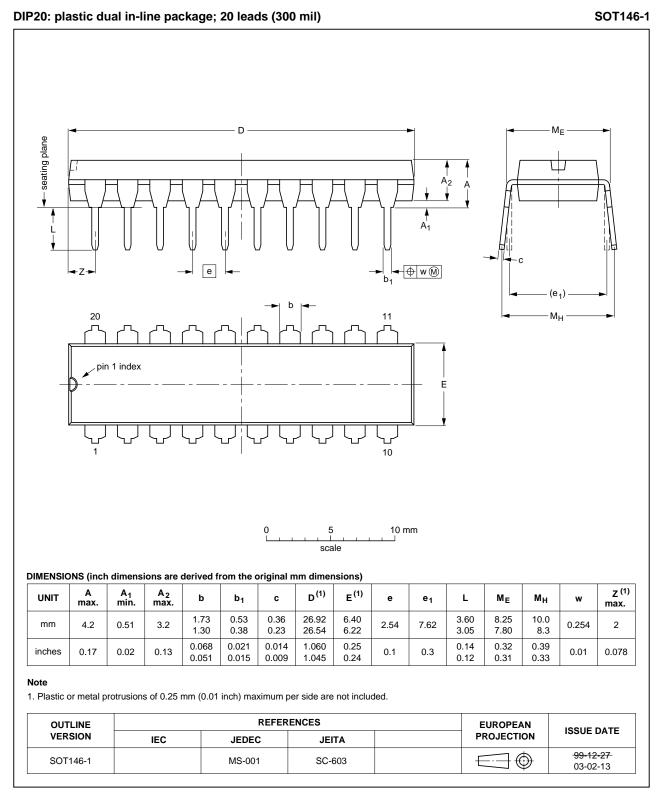


### Table 9. Test data

Туре	Input		Load		S1 position		
	VI	t <sub>r</sub> , t <sub>f</sub>	CL	RL	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>
74HC244	V <sub>CC</sub>	6 ns	15 pF, 50 pF	1 kΩ	open	GND	V <sub>CC</sub>
74HCT244	3 V	6 ns	15 pF, 50 pF	1 kΩ	open	GND	V <sub>CC</sub>

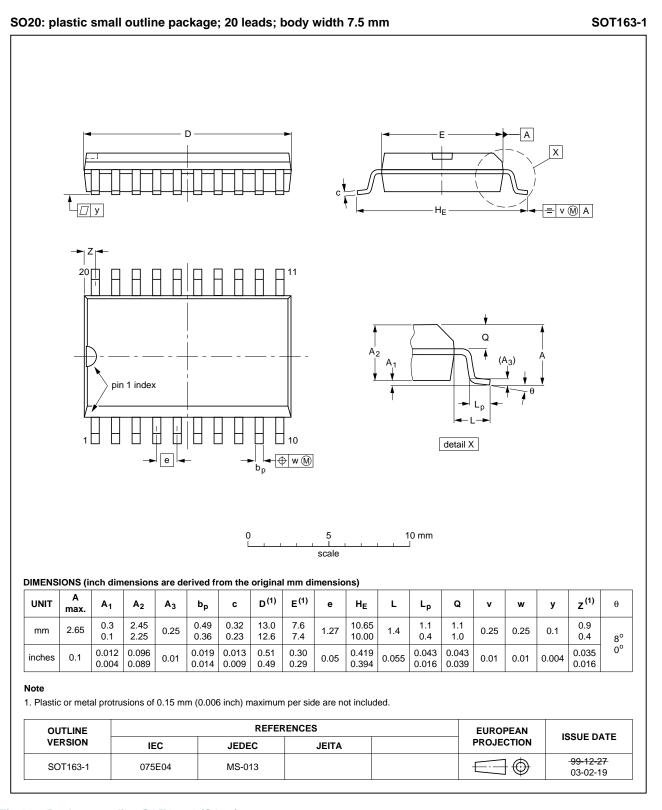
Octal buffer/line driver; 3-state

## 12. Package outline



### Fig 9. Package outline SOT146-1 (DIP20)

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### Fig 10. Package outline SOT163-1 (SO20)

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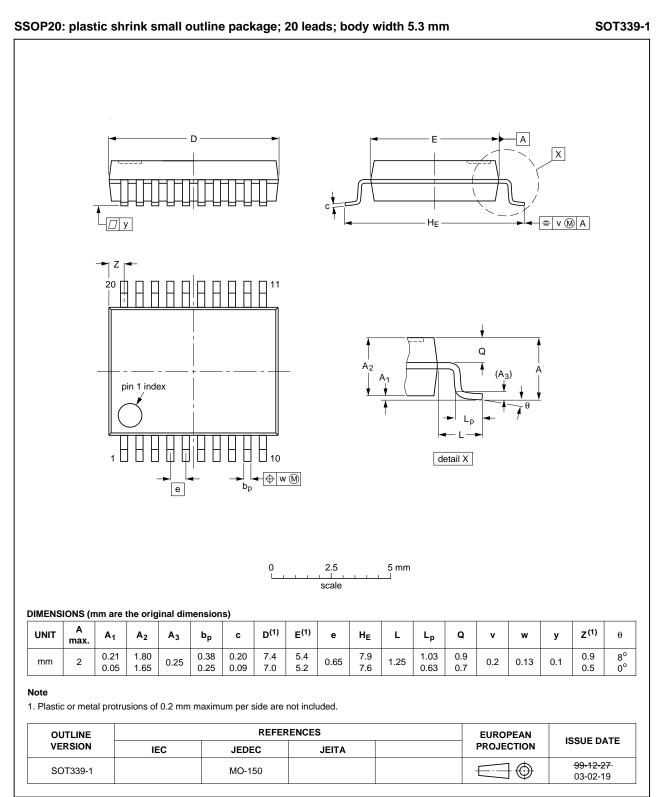
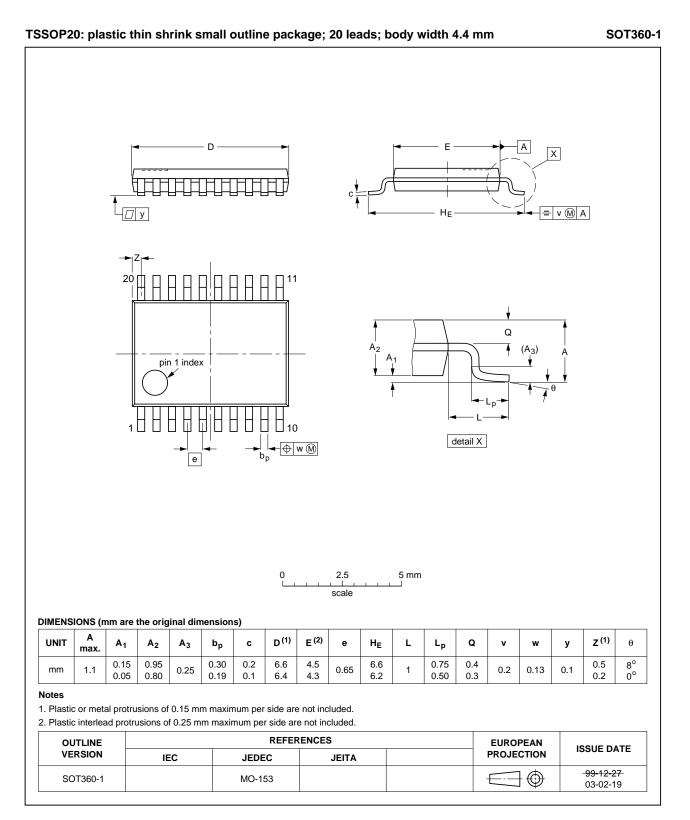


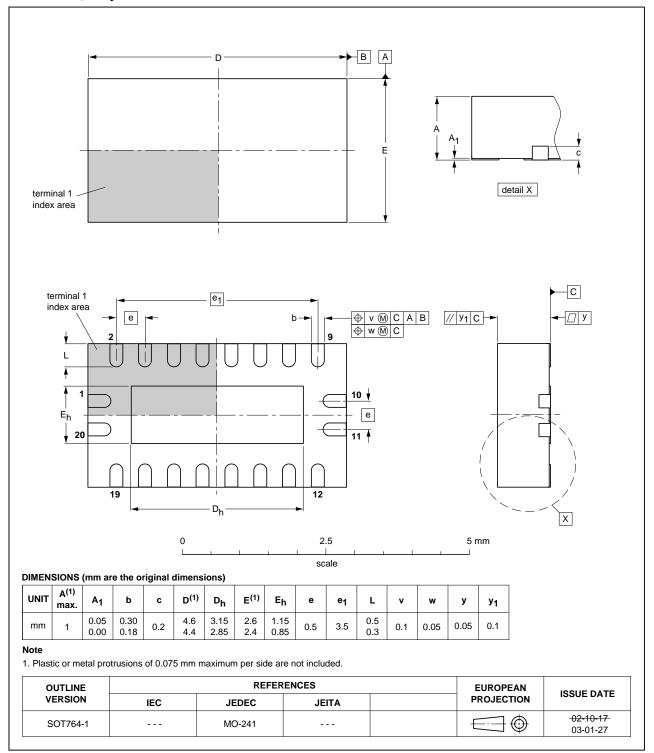
Fig 11. Package outline SOT339-1 (SSOP20)

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#### Fig 12. Package outline SOT360-1 (TSSOP20)

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DHVQFN20: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 20 terminals; body 2.5 x 4.5 x 0.85 mm SOT764-1

### Fig 13. Package outline SOT764-1 (DHVQFN20)

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# **13. Abbreviations**

Table 10. Abbreviations				
Acronym	Description			
CMOS	Complementary Metal Oxide Semiconductor			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
HBM	Human Body Model			
MM	Machine Model			
TTL	Transistor-Transistor Logic			

# 14. Revision history

Table 11. Revision histor	ry				
Document ID	Release date	Data sheet status	Change notice	Supersedes	
74HC_HCT244 v.4	20120924	Product data sheet	-	74HC_HCT244 v.3	
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>				
<ul> <li>Legal texts have been adapted to the new company name where appropria</li> </ul>					
74HC_HCT244 v.3	20051222	Product data sheet	-	74HC_HCT244_CNV v.2	
74HC_HCT244_CNV v.2	19901201	Product specification	-	-	

## 15. Legal information

#### 15.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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## **17. Contents**

1	General description 1
2	Features and benefits 1
3	Ordering information 1
4	Functional diagram 2
5	Pinning information 3
5.1	Pinning 3
5.2	Pin description 3
6	Functional description 4
7	Limiting values 4
8	Recommended operating conditions 4
9	Static characteristics 5
10	Dynamic characteristics 6
11	Waveforms 8
12	Package outline 10
13	Abbreviations 15
14	Revision history 15
15	Legal information 16
15.1	Data sheet status 16
15.2	Definitions 16
15.3	Disclaimers
15.4	Trademarks 17
16	Contact information 17
17	Contents 18

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